

Search Notes

Application/Control No.

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Examiner

Shih-Chao Chen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
343	754, 770, 771, 772, 776, 909	1/23/2006	CHEN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
343	754, 770	1/23/2006	CHEN
343	776	1/23/2006	CHEN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (SEARCH UPDATED).	1/23/2006	CHEN